TOSHIBA 1SV214

TOSHIBA VARIABLE CAPACITANCE DIODE SILICON EPITAXIAL PLANAR TYPE

1 S V 2 1 4

TV TUNING

Unit in mm

High Capacitance Ratio : C2V/C25V = 6.5 (Typ.)

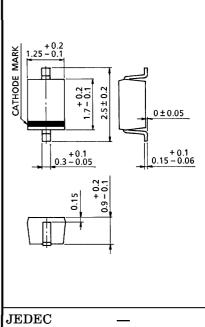
Low Series Resistance : $r_s = 0.4\Omega$ (Typ.)

Excellent C-V Characteristics, and Small Tracking Error.

Useful for Small Size Tuner.

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Reverse Voltage	$v_{ m R}$	30	V
Peak Reverse Voltage	v_{RM}	$(R_L = 10 \mathrm{k}\Omega)$	V
Junction Temperature	$T_{ m j}$	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	$^{\circ}\mathrm{C}$



JEDEC	_	
EIAJ	_	
TOSHIBA	1-1E1A	

Weight: 0.004g

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT	
Reverse Voltage	v_{R}	$I_R = 1 \mu A$	30	_	_	V	
Reverse Current	$I_{\mathbf{R}}$	$V_R = 28V$	_	_	10	nA	
Capacitance	C2V	$V_R=2V, f=1MHz$	14.16	_	16.25	рF	
Capacitance	C25V	$V_R = 25V, f = 1MHz$	2.11	_	2.43	pF	
Capacitance Ratio	C2V / C25V	-	5.90	6.50	7.15	_	
Series Resistance	$r_{\rm S}$	$V_R=5V$, $f=470MHz$	_	0.4	0.55	Ω	

(Note 1): Units are compounded in one package and are matched to 2.5%.

$$\frac{C(\text{Max.}) - C(\text{Min.})}{C(\text{Min.})} \leq 0.025$$
$$(V_R = 2 \sim 25V)$$





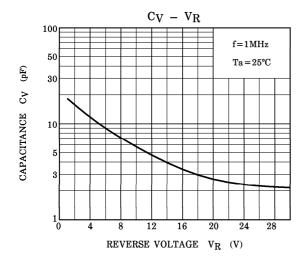
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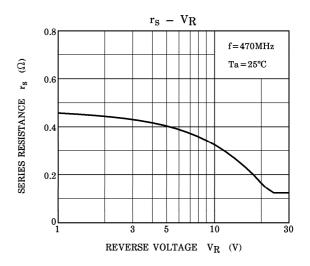
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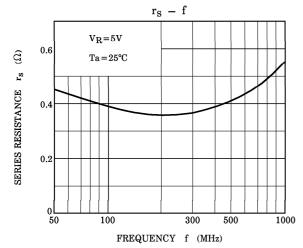
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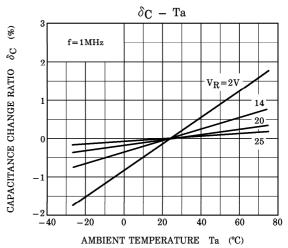
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NOTE:
$$\delta_{\text{C}} = \frac{\text{C (Ta)} - \text{C (25)}}{\text{C (25)}} \times 100$$